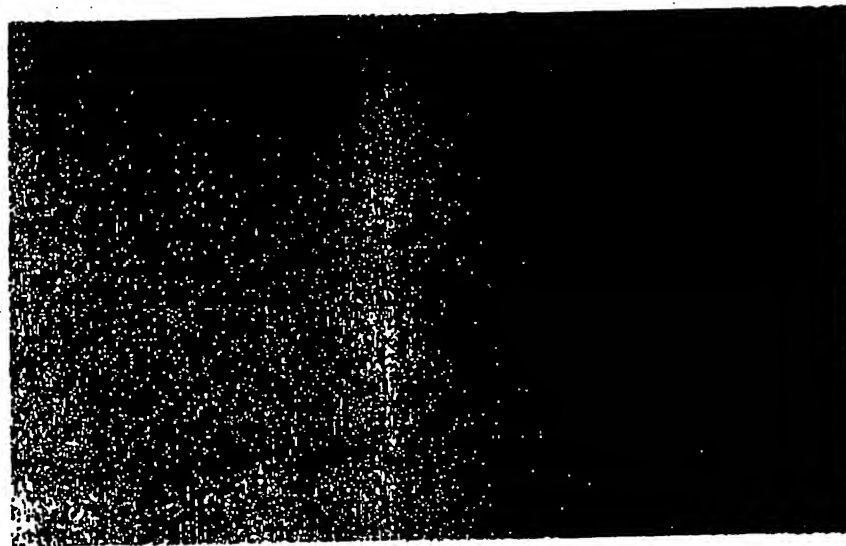
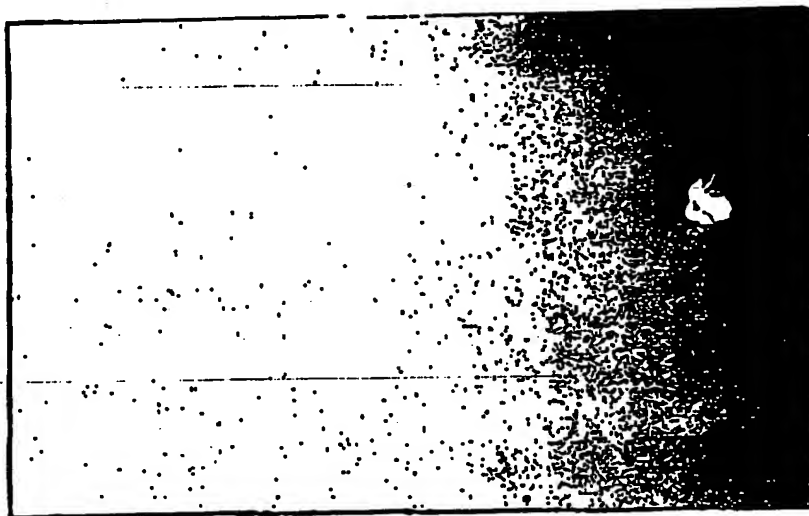


FIG. 5



SURFACE MORPHOLOGY B (250 μm \times 190 μm)

FIG. 6



SURFACE MORPHOLOGY A (250 μm \times 190 μm)

FIG. 7

OFF ANGLE BETWEEN NORMAL LINE ON SURFACE OF ZrB_2 SUBSTRATE
 AND $[0001]$ AXIS, AND SURFACE MORPHOLOGY

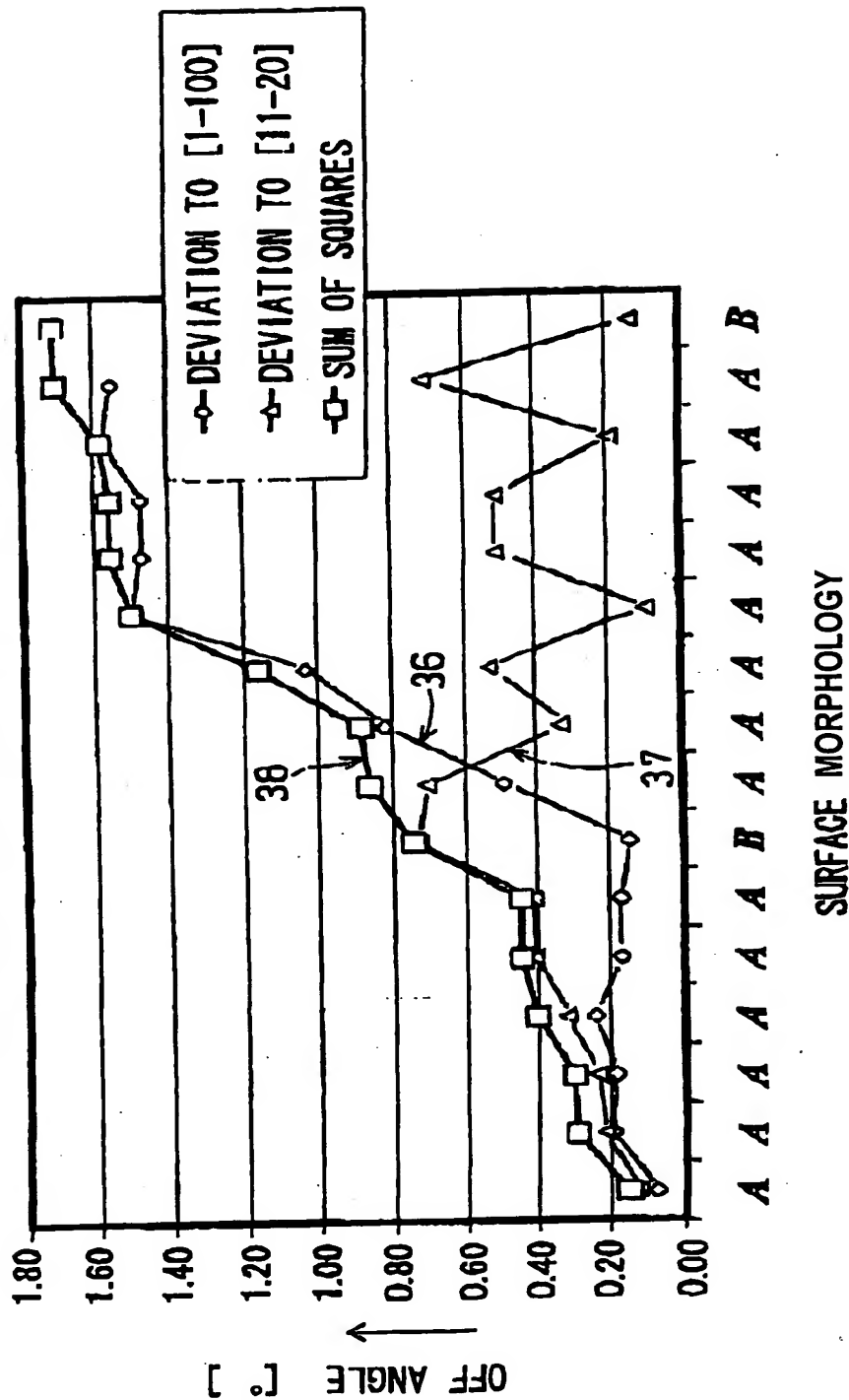
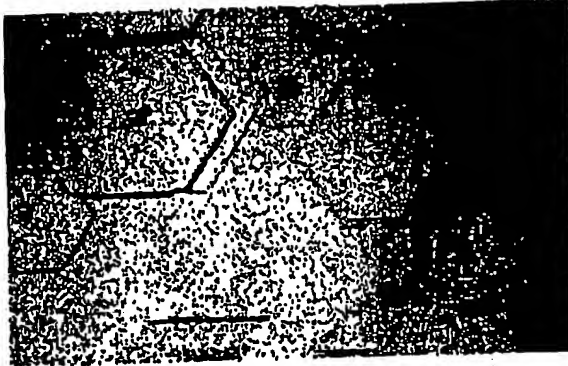


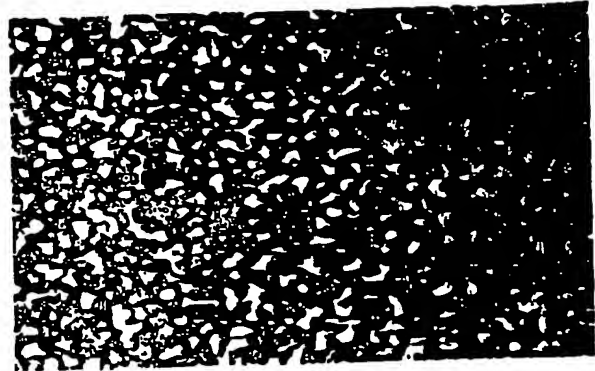
FIG. 9

(5)

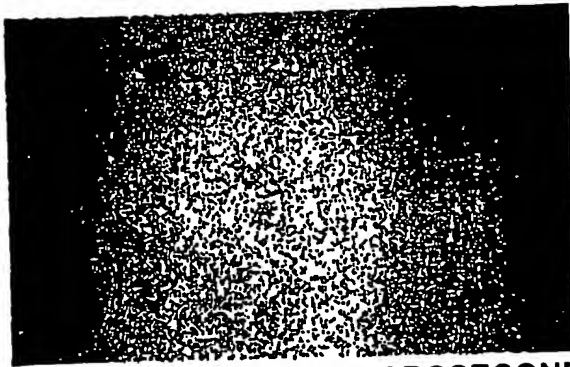


1100°C OR MORE 0.25 873 ARCSECONDS 400°C 0.8 —

(1)

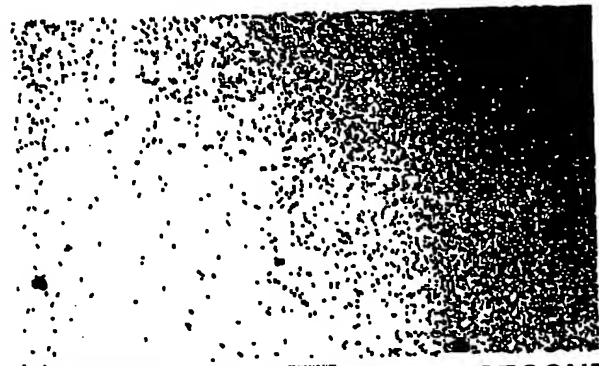


(2)



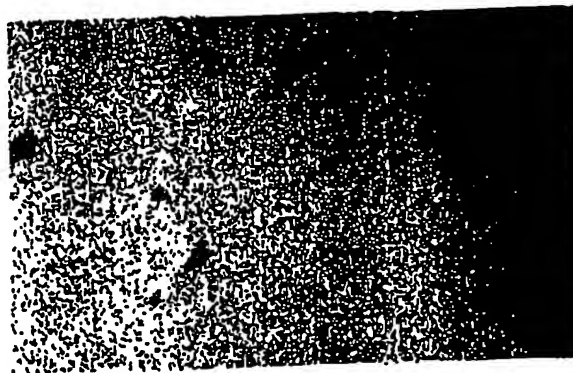
725°C 0.6 760 ARCSECONDS

(3)



850°C 0.5 596 ARCSECONDS

(4)



925°C 0.4 —

FIG. 10

RELATION BETWEEN FILM THICKNESS OF
 $(\text{AlN})_x(\text{GaN})_{1-x}$ AND X-RAY FWHM (TILT)

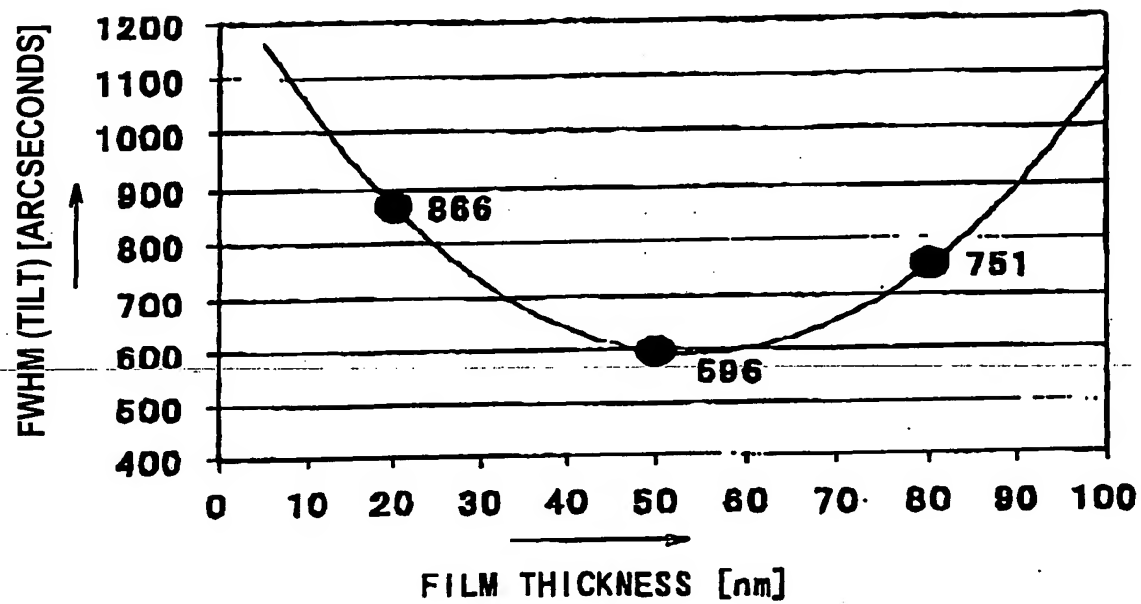


FIG. 11

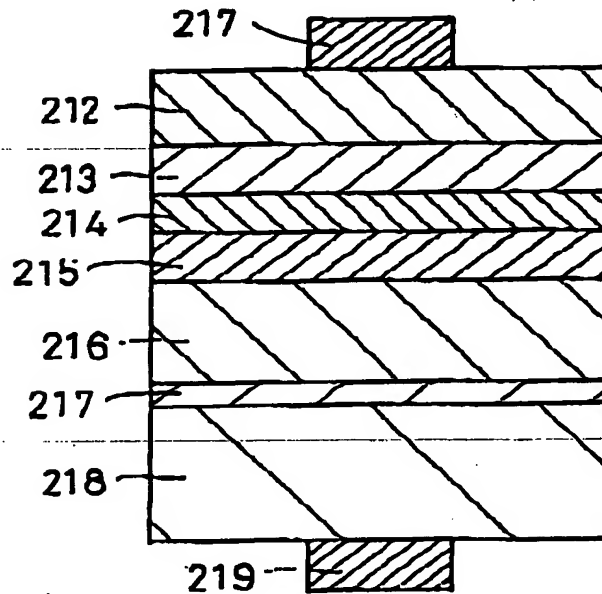


FIG. 12

RELATION BETWEEN OFF ANGLE OF NORMAL LINE OF SURFACE OF ZrB_2 SUBSTRATE
 FROM [0001] CRYSTAL AXIS AND SURFACE MORPHOLOGY OF GaN
 EPITAXY FILM

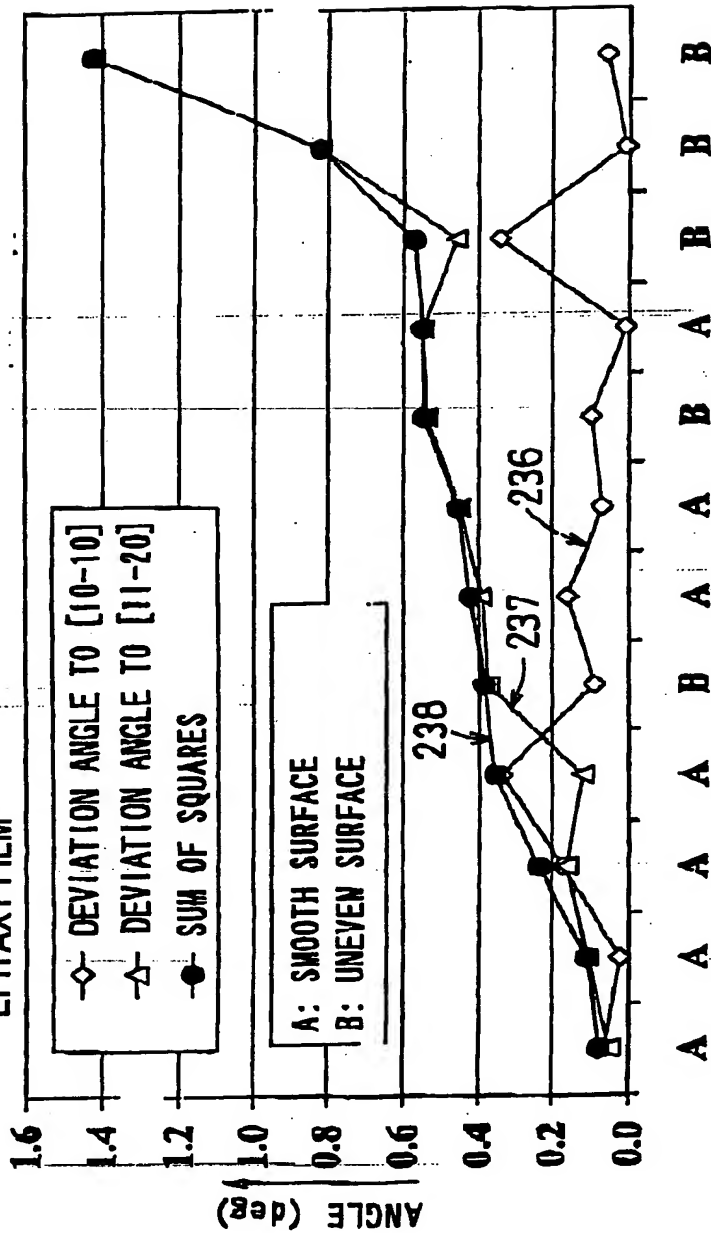
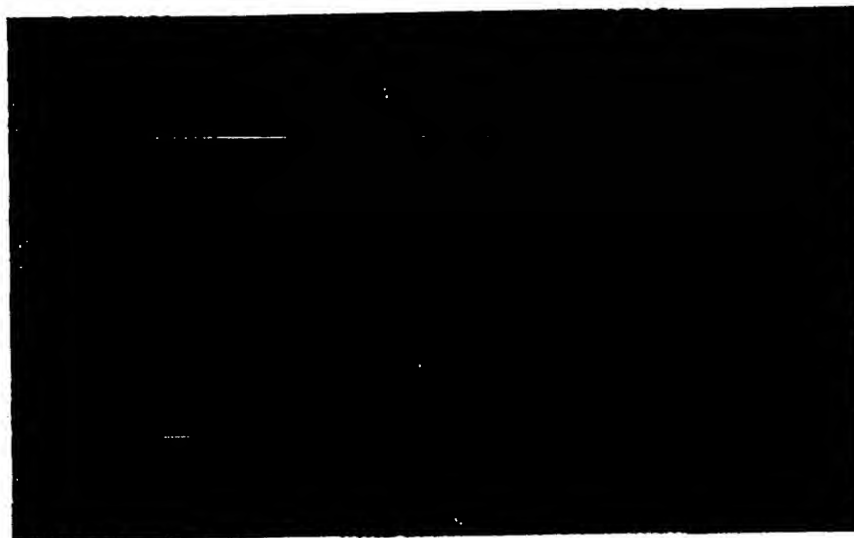


FIG. 13



SURFACE MORPHOLOGY B (250 μm \times 190 μm)

FIG. 14



SURFACE MORPHOLOGY A (250 μm \times 190 μm)

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